155Mbps/622Mbps/1.25Gbps/2.5Gbps

High Speed InGaAs Photodiodes

FCI-InGaAs-XXX series with active area sizes of, 75µm, 120µm, 300µm, 400µm and 500µm, exhibit the characteristics need for Datacom and Telecom applications. Low capacitance, low dark current and high responsivity from 1100nm to 1620nm make these devices ideal for high-bit rate receivers used in LAN, MAN, WAN, and other high speed communication systems. The photodiodes are packaged in 3 lead isolated TO-46 cans or with AR coated flat windows or micro lenses to enhance coupling efficiency. FCI-InGaAs-XXX series is also offered with FC, SC, ST and SMA receptacles.

APPLICATIONS

- High Speed Optical Communications
- Single/Multi-Mode Fiber Optic Receiver
- Gigabit Ethernet/Fibre Channel
- SONET/SDH, ATM
- Optical Taps

FEATURES

- High Speed
- High Responsivity
- Low Noise
- Spectral Range
 900nm to 1700nm



Absolute Maximum Ratings									
PARAMETERS	SYMBOL	MIN	МАХ	UNITS					
Storage Temperature	T _{stg}	-55	+125	°C					
Operating Temperature	T _{op}	-40	+75	°C					
Soldering Temperature	T _{sld}		+260	°C					

Electro-Optical Characteristics T _A =23°C																		
PARAMETERS	SYMBOL	CONDITIONS		InGaA			InGaAs	· · · · · · · · · · · · · · · · · · ·		InGaA		-	InGaAs			-InGaA	s-500	UNITS
TARATETERS	0111002	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	01110
Active Area Diameter	AA_{ϕ}			75			120			300			400			500		μm
Responsivity	D	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
(Flat Window Package)	R _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		
Capacitance	Cj	V _R = 5.0V		1.5			2.0			10.0			14.0			20.0		pF
Dark Current	I _d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_{R} = 5.0V,$ $R_{L} = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Reverse Voltage					20			20			15			15			15	v
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

Phone +49 (0) 8152 983 789-0

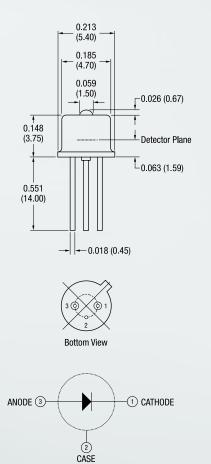
 Phone
 +49 (0) 8152 983 789-0

 Fax
 +49 (0) 8152 983 789-1

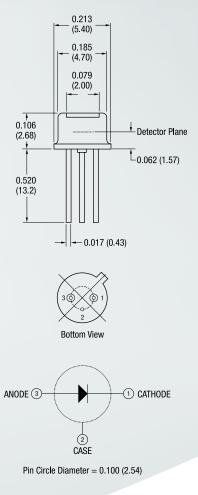
 E-Mail
 info@sphereoptics.de

 www.sphereoptics.de

155Mbps/622Mbps/1.25Gbps/2.5Gbps High Speed InGaAs Photodiodes



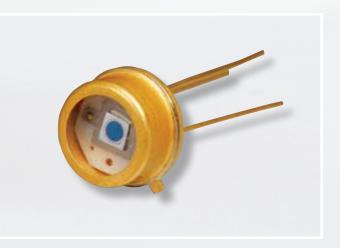
Pin Circle Diameter = 0.100 (2.54)



- All units in inches (mm).
- All tolerances: 0.005 (0.125).
- Please specify when ordering the flat window or lens cap devices.
- The flat window devices have broadband AR coatings centered at 1310nm.
- The thickness of the flat window=0.008 (0.21).

FCI-InGaAs-XXX-X Large Active Area InGaAs Photodiodes

FCI-InGaAs-XXX-X series with active area sizes of 1mm, 1.5mm and 3mm, are part of OSI Optoelectronics's large active area IR sensitive detectors which exhibit excellent responsivity from 1100nm to 1620nm, allowing high sensitivity to weak signals. These large active area devices are ideal for use in infrared instrumentation and monitoring applications. The photodiode chip are isolated in TO-46 or TO-5 packages with a broadband double sided AR coated flat window. FCI-InGaAs-3000-X come with different shunt resistance values of 5, 10, 20, and $40M\Omega$.



APPLICATIONS

FEATURES • High Responsivity

- Optical Instrumentation Power Measurement
 - Large Active Area Diameter
 - Low Noise
- Medical Devices

IR Sensing

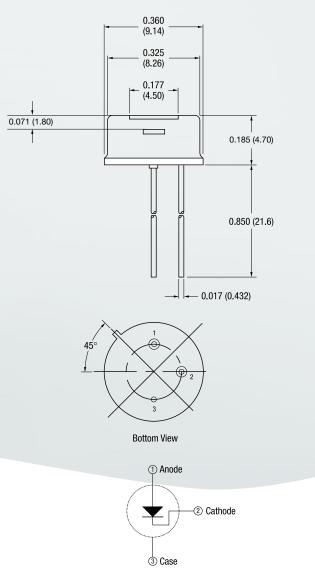
Spectral Range 900nm to 1700nm

Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-55	+125	°C						
Operating Temperature	T _{op}	-40	+75	°C						
Soldering Temperature	T _{sld}		+260	°C						

Electro-Optical C	Electro-Optical Characteristics T _A =23°C												
PARAMETERS	SYMBOL	CONDITIONS	FC	[-InGaAs-1	000 FCI-InGaAs-1500			FCI	InGaAs-30	00-X	UNITS		
PARAMETERS	STMBOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	ТҮР	MAX	UNITS	
Active Area Diameter	AA _¢			1.0			1.5			3.0		mm	
Deenersiisiite	R _λ	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		A ()A(
Responsivity		λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		A/W	
Capacitance	Cj	V _R =0V		80	200		200	450		750	1800	pF	
Shunt Resistance	R _{SH}	V _R =10mV	30				20			20		MΩ	
Max. Reverse Voltage					5			2			2	v	
Max. Reverse Current					1			2			2	mA	
Max. Forward Current					10			10			10	mA	
NEP				2.45E-14			3.01E-14			4.25E-14		W/√Hz	

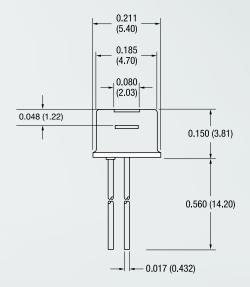
FCI-InGaAs-XXX-X Large Active Area InGaAs Photodiodes

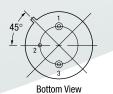
FCI-InGaAs-3000-X

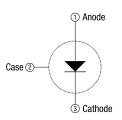


Pin Circle Diameter = 0.200 (5.08)

FCI-InGaAs-1000 & FCI-InGaAs-1500







Pin Circle Diameter = 0.100 (2.54)

- All units in inches (mm).
- All tolerances: 0.005 (0.125)
- The flat window devices have broadband AR coatings centered at 1310nm
- The thickness of the flat window=0.008 (0.21)

FCI-InGaAs-QXXX Large Active Area InGaAs Quadrants

FCI-InGaAs-QXXX series are large active area InGaAs photodiodes segmented into four separate active areas. These photodiodes come in 1mm and 3mm active area diameter. The InGaAs Quad series with high response uniformity and the low cross talk between the elements are ideal for accurate nulling or centering applications as well as beam profiling applications. They exhibit excellent responsivity from 1100nm to 1620nm, and are stable over time and temperature, and fast response times necessary for high speed or pulse operation. The photodiodes are packaged in isolated TO-5 or TO-8 cans with a broadband double sided AR coated flat window, and also can be mounted on ceramic substrate per request.



• Position Sensing

Beam Alignment

Beam Profiling

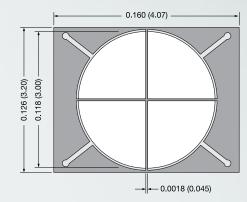
FEATURES

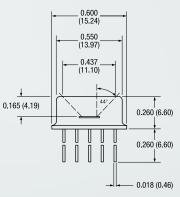
- High Responsivity
- Low Noise
- Spectral Range 900nm to 1700nm
- Low Crosstalk
- Wide Field of View

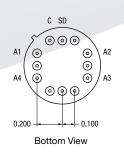
Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-55	+125	°C						
Operating Temperature	T _{op}	-40	+75	°C						
Soldering Temperature	T _{sld}		+260	°C						

Electro-Optical C	Electro-Optical Characteristics (per 1 element) T _A =23°C												
PARAMETERS	SYMBOL	CONDITIONS	FCI	-InGaAs-Q1	000	FCI	-InGaAs-Q3	000	UNITS				
FARAPILIERS	STRIBUL	CONDITIONS	MIN	ТҮР	MAX	MIN	ТҮР	MAX	UNITS				
Active Area Diameter	AA_{ϕ}			1000			3000		μm				
Responsivity	esponsivity R,	λ=1310nm	0.85	0.90		0.85	0.90		A/W				
Responsivity	κ _λ	λ=1550nm	0.90	0.95		0.90	0.95		A/ W				
Element Gap				0.045			0.045		mm				
Capacitance	Cj	V _R = 5.0V			25			225	pF				
Dark Current	I _d	V _R = 5.0V		0.5	15		2.0	100	nA				
Rise Time/ Fall Time	t _r /t _f	V _R = 5.0V, 50Ω 10% to 90%		3			24		ns				
Crosstalk		$\lambda = 1550$ nm, V _R = 5.0V			1			1	%				
Max. Reverse Voltage					15			10	V				
NEP		λ=1550nm		1.20E-14			2.50E-14		W/√Hz				

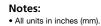
InGaAs-Q3000



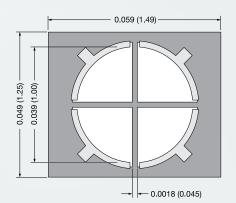


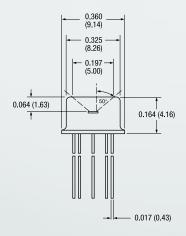


	Pinout								
PIN	Description								
A1	ANODE QUADRANT 1								
A2	ANODE QUADRANT 2								
A3	ANODE QUADRANT 3								
A4	ANODE QUADRANT 4								
С	COMMON CATHODE								
SD	SUCTION DIODE								











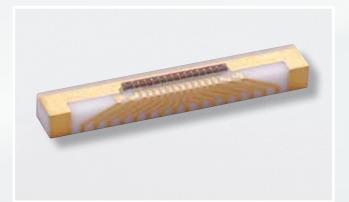
Pin Circle Dia.=0.230 Bottom View

Pinout

PIN	Description							
A1	ANODE QUADRANT 1							
A2	ANODE QUADRANT 2							
A3	ANODE QUADRANT 3							
A4	ANODE QUADRANT 4							
С	COMMON CATHODE							

FCI-InGaAs-XXM High Speed InGaAs Arrays

FCI-InGaAs-XXM series with 4, 8, 12 and 16 channels are parts of OSI Optoelectronics's high speed IR sensitive photodetector arrays. Each AR coated element is capable of 2.5Gbps data rates exhibiting high responsivity from 1100nm to 1620nm. FCI-InGaAs-XXM, which comes standard on a wraparound ceramic submount, is designed for multichannel fiber applications based on standard 250mm pitch fiber ribbon. Also, board level contacts of 500mm make it easy to connect to your circuit.



APPLICATIONS

FEATURES

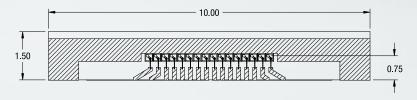
- High Speed Optical Communications
- Single/Multi-Mode Fiber Optic Receiver
 High Responsivity
- Gigabit Ethernet/Fibre Channel
- SONET/SDH, ATM
- Optical Taps

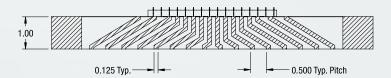
- High Speed
- Low Noise
- Spectral Range 900nm to 1700nm

Electro-Optical Charact	eristics		T,	_=23°C, V _R =5V						
PARAMETERS	FCI-InGaAs-4M	FCI-InGaAs-4M FCI-InGaAs-8M FCI-InGaAs-12M FCI-InGa								
Active Area Diameter		75µm, Pitch:250µm								
Responsivity	Typ. 0.95A/W @1550nm									
Capacitance	Тур. 0.65рF									
Dark Current	Typ. 0.03nA									
Max. Reverse Voltage			20V							
Max. Forward Current		:	5mA							
Bandwidth		Typ. 2.0G	Hz @ 1550nm							
Breakdown Voltage		Ту	p. 50V							
Storage Temperature Range		From -	40 to 85°C							
Operating Temperature Range		From	0 to 70°C							

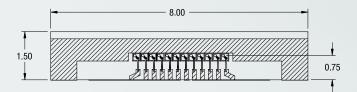
FCI-InGaAs-XXM High Speed InGaAs Arrays

FCI-InGaAs-16M

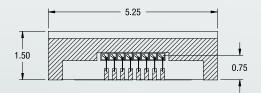


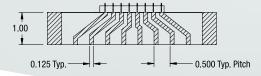


FCI-InGaAs-12M



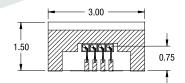
FCI-InGaAs-8M

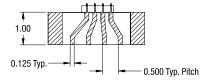




1.00 0.125 Typ. - - 0.500 Typ. Pitch

FCI-InGaAs-4M





Notes:

All units in millimeters.

 All devices are mounted with low out gassing conductive epoxy with tolerance of ±25µm.

1.25Gbps / 2.50Gbps Hybrids

InGaAs Photodetectors / Transimpedance Amplifiers

FCI-H125/250G-InGaAs-XX series are compact and integrated high speed InGaAs photodetector with wide dynamic range transimpedance amplifier. Combining the detector with the TIA in a hermetically sealed 4 pin TO-46 package provides ideal conditions for high speed signal amplification. High speed and superior sensitivity make these devices ideal for high-bit rate receivers used in LAN, MAN, WAN, and other high speed communication systems. TO packages come standard with a lensed cap to enhance coupling efficiency, or with a broadband double sided AR coated flat window. The FCI-H125/250G-InGaAs-XX series are also offered with FC, SC, ST and SMA receptacles.

APPLICATIONS

FEATURES

- High Speed Optical Communications
- Gigabit Ethernet
- Fibre Channel
- ATM
- SONET OC-48 / SDH STM-16
- InGaAs Photodetector / Low Noise Transimpedance Amplifier
- High Bandwidth / Wide Dynamic Range
- Hermetically Sealed TO-46 Can
- Single +3.3 to +5V Power Supply
- Spectral Range 1100nm to 1650nm
- Differential Output



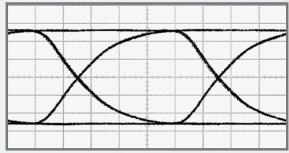


Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-40	+125	°C						
Operating Temperature	T _{op}	-40	+85	°C						
Supply Voltage	V _{cc}	0	+5.5	V						
Input Optical Power	P _{IN}		+3	dBm						

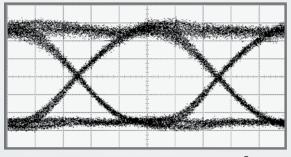
Electro-Optical Charac	teristics		T _A =23°	C, Vcc=+	3.3V, 13	10nm, 1(00 Ω Diffe	rential A	C Load
PARAMETERS	SYMBOL	CONDITIONS	FCI-H1	25G-InG	aAs-75	FCI-H2	50G-InG	aAs-75	UNITS
PARAMETERS	STHEOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Supply Voltage	V _{cc}		+3		+5.5	+3		+5.5	v
Supply Current	I _{CC}	*T _A = 0 to 70°C		26	*55		35	*65	mA
Active Area Diameter	AA_{ϕ}			75			75		μm
Operating Wavelength	λ		1100		1650	1100		1650	nm
Responsivity	R _λ	-17dBm, Differential	1800	2500		1600	2500		V/W
Transimpedance		-17dBm, Differential		2800			2800		Ω
Sensitivity	S	BER 10 ⁻¹⁰ , PRBS2 ⁷ -1	-24	-28		-20	-24		dBm
Optical Overload			-3			0			dBm
Bandwidth	BW	-3dB, Small Signal		900			1750		MHz
Low Frequency Cutoff		-3dB		45			30		kHz
Differential Output Voltage	V _{OUT, P-P}	-3dBm	180	250	420	200	400	600	mV _{P-P}
Output Impedance			47	50	53	47	50	53	Ω
Transimpedance Linear Range		<5%	30			40			μW _{P-P}

Use AC coupling and differential 100Ω load for best high-speed performance. Devices are not intended to drive DC coupled, 50Ω grounded load.

FCI-H125G-InGaAs-75

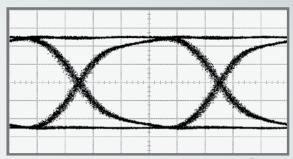


50mV / div, 160ps / div, -6dBm, 1310nm, PRBS27-1, Diff.

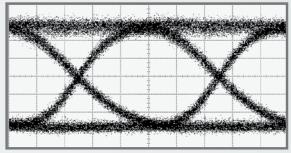


8mV / div, 160ps / div, -21dBm, 1310nm, PRBS27-1, Diff.

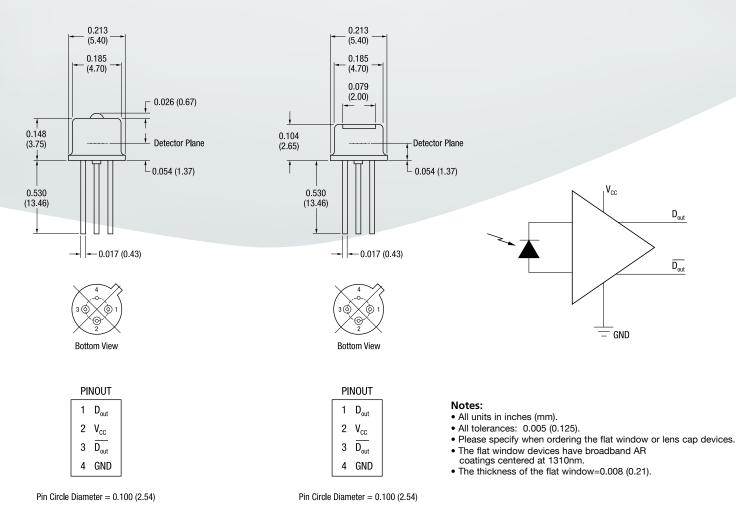
FCI-H250G-InGaAs-75



⁸⁰mV / div, 80ps / div, -6dBm, 1310nm, PRBS27-1, Diff.



¹⁰mV / div, 80ps / div, -19dBm, 1310nm, PRBS27-1, Diff.



622 Mbps Hybrids InGaAs Photodetectors / Transimpedance Amplifiers

FCI-H622M-InGaAs-75 series are high-speed 75µm InGaAs photodetector integrated with wide dynamic range transimpedance amplifier. Combining the detector with the TIA in a hermetically sealed 4 pin TO-46 package provides ideal conditions for high-speed signal detection and amplification. Low capacitance, low dark current and high responsivity of the detector, along with low noise characteristic of the integrated TIA, give rise to excellent sensitivity. In practice, these devices are ideal for datacom and telecom applications. Cost effective TO-46 packages come standard with a lensed cap for design simplification, or with a broadband double-sided AR coated flat window. The FCI-H622M-InGaAs-75 series are also offered with FC, SC, ST and SMA receptacles.

APPLICATIONS

FEATURES

 High Speed Optical Communications

• SDH STM-1 / STM-4 Optical Receivers

- ATM
- High Bandwidth / Wide Dynamic Range • Single +3.3V Power Supply

• Low Noise Transimpedance Amplifier

- SONET OC-3 / OC-12
 - Spectral Range 1100nm to 1650nm
 - Differential Output

Absolute Maximum	Ratings							
PARAMETERS SYMBOL MIN MAX UNITS								
Storage Temperature	T _{stg}	-40	+125	°C				
Operating Temperature	T _{op}	-40	+85	°C				
Supply Voltage	V _{cc}	0	+5.5	v				
Input Optical Power	P _{IN}		+3	dBm				

Electro-Optical Characteristics

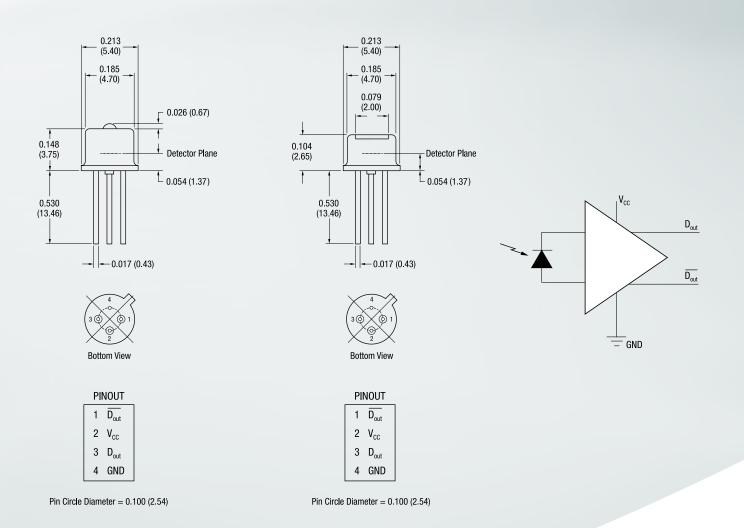
Electro-Optical Characte	ristics	T=23°	C, Vcc=+3	3.3V, 13	10nm, 15	50 Ω Differential AC at 622Mbps
PARAMETERS	SYMBOL	CONDITIONS	FCI-H6	22M-InG	GaAs-75	UNITS
PARAMETERS	STHEOL	CONDITIONS	MIN	TYP	MAX	00113
Supply Voltage	V _{cc}		+3		+3.6	V
Supply Current	I _{CC}	$*T_{A} = 0$ to 70°C		22	27	mA
Active Area Diameter	AA_{ϕ}			75		μΜ
Operating Wavelength	λ		1100		1650	nm
Responsivity	R _λ	*-37dBm, -28dBm Differential		16		V/mW
Transimpedance		*-37dBm, -28dBm Differential		18		kΩ
Sensitivity	S	BER 10 ⁻⁹ , PRBS2 ⁷ -1 with noise filter		-32		dBm
Optical Overload				0		dBm
Bandwidth	BW	-3dB, Small Signal		520		MHz
Differential Output Voltage	V _{OUT, P-P}	0dBm		240		mV _{P-P}
Output Impedance		Single-ended		75		Ω

Use AC coupling and differential 150 Ω load for the best high-speed performance. Devices are not designed to drive DC coupled 150 Ω grounded load.





622 Mbps Hybrids InGaAs Photodetectors / Transimpedance Amplifiers



- All units in inches (mm).
- All tolerances: 0.005 (0.125).
 Please specify when ordering the flat window or lens cap devices.
- The flat window devices have a double sided AR coated window at 1310nm.
- The thickness of the flat window=0.008 (0.21).

FCI-InGaAs-300B1XX Back Illuminated InGaAs Photodiode / Arrays

FCI-InGaAs-300B1XX series are multifunctional backside illuminated photodiode/arrays. They come standard in a single element diode or 4- or 8- elements array with active area of 300um. These back illuminated InGaAs photodiode/arrays are designed to be flip chip mounted to an optical plane for front or back illumination. They can be traditionally mounted (active area facing up), or assembled face down minimizing the overall dimensions. These low inductance, low dark current, and low capacitance back illuminated photodiode/ arrays come with or without ceramic substrates.

APPLICATIONS

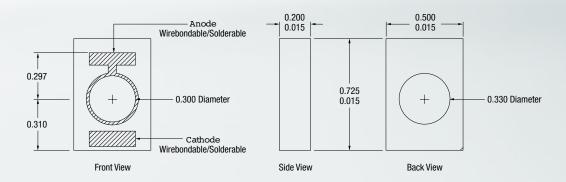
- High Speed Optical Communications
- Multichannel Fiber Optic Receiver
- Power Monitoring
- Single/Multi-Mode Fiber Optic Receiver
- Fast Ethernet, SONET/SDH OC-3/STM-1, ATM
- Instrumentation and Analog Receivers
- FEATURES
- Back Illumination
- High Responsivity on Both Front and Back
- Low Noise
- Spectral Range 900nm to 1700nm

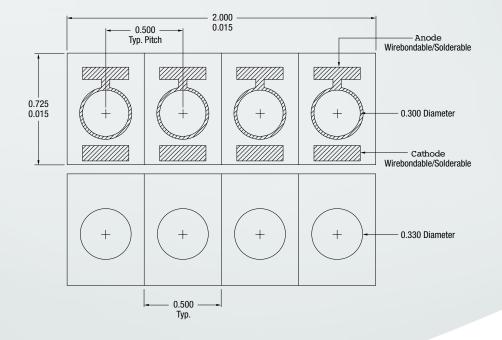
Electro-Optical Charact	eristics		$T_A = 23^{\circ}C, V_R = 5V$						
PARAMETERS	FCI-InGaAs-300B1	FCI-InGaAs-300B1X4	FCI-InGaAs-300B1X8						
Active Area Diameter	300µm	300µm, Pitch:500µm	300µm, Pitch:500µm						
Responsivity		/W @ 1550nm for both fror /W @ 1310nm for both fror							
Capacitance	Ту	Typ. 8pF, Max. 10pF @ V _R =-5V							
Dark Current	Тур.	0.05nA, Max. 5.0nA @ V _R =	5V						
Max. Reverse Voltage		15V							
Max. Reverse Current		5mA							
Max. Forward Current		25mA							
Bandwidth		Min. 100MHz							
Breakdown Voltage		Min. 10V @ 1uA							
Storage Temperature Range	From −40 to 85°C								
Operating Temperature Range		From 0 to 70°C							

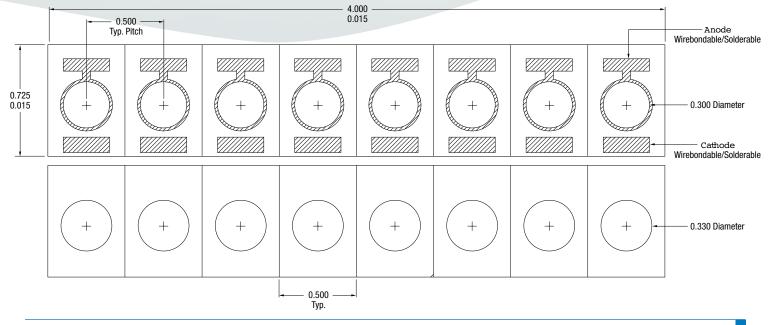


FCI-InGaAs-300B1XX

Back Illuminated InGaAs Photodiode / Arrays

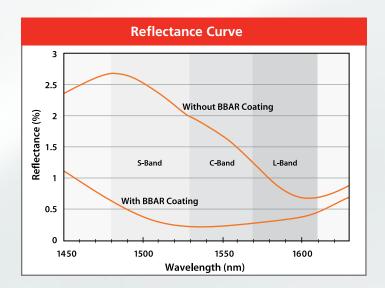






FCI-InGaAs-WCER-LR Broadband Anti-Reflection Coated InGaAs Photodiodes

OSI Optoelectronics's latest product line includes a very low reflectance photodiode. Designed for telecommunication applications, the InGaAs/InP photodiode has a typical optical reflectance of less than .6% from 1520nm to 1620nm. This ultra low reflectance over the wide wavelength range was achieved by depositing a proprietary multi-layered Anti-Reflection coating directly onto the surface of the InGaAs/InP photodiode.



Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-40	+85	°C						
Operating Temperature	T _{op}	0	+70	°C						
Soldering Temperature	T _{sld}		+260	°C						

Electro-Optio	cal Charac	teristics			T,	_=23°C
PARAMETERS	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS
Active Area	AA			250X500		μm Χ μm
Deepensivity	P	λ = 1310nm	0.85	0.90		A /\A/
Responsivity	R _λ	$\lambda = 1550$ nm	0.90	0.95		A/W
Capacitance	Cj	V _R =5.0V		15		pF
Dark Current	I _d	V _R =5.0V			1	nA
Max. Reverse Voltage					20	v
Max. Reverse Current					2	mA
Max. Forward Current					5	mA
Reflectance		1520nm≤ λ ≤1620nm		0.5	0.6	%

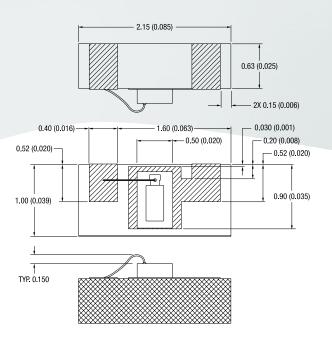


APPLICATIONS

- Wavelength Locker / Wavelength Monitoring
- Lasers Back Facet Monitoring
- DWDM
- Instrumentation

FEATURES

- Reflectance Less than 0.6%
- Low Noise
- High ResponsivityHigh Speed
- Spectral Range 900nm to 1700nm



- All units in millimeters.
- All devices are mounted with low out gassing conductive epoxy with tolerance of ±25µm. Eutectic mounting is also available upon request.

FCI-InGaAs-36C 10Gbps InGaAs Photodiode

OSI Optoelectronics's FCI-InGaAs-36C is an OC-192 (SONET/SDH) capable photosensitive device, exhibiting low dark current and good performance stability.

Both Anode and Cathode contacts appear on the chip's top facet. And it makes ideal component in high-speed optical data transport applications at 10Gbps, responding to a spectral envelop that spans from 910nm to 1650nm.

APPLICATIONS

Communications

Optical Networking

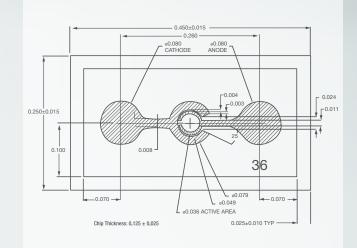
• Optical Measurement

• OC-192

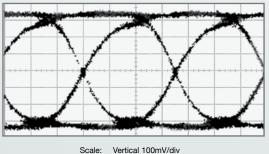
- High Speed Optical
 - High Speed, 10 Gbps Data Rates
 - low Dark Current
 - Front Illuminated

FEATURES

- High Responsivity, Typ. 0.8 A/W
 @1550nm
- Diameter of Light Sensitive area 36µm
- Low Capacitance



Typical Eye Diagram (10Gbps)⁽¹⁾



Horizontal 20.0 ps/div

Electro-Optical C	haracteris	stics				T _A =23°C
PARAMETERS	SYMBOL	CONDITIONS	MIN	ТҮР	мах	UNITS
Sensing Area Diameter	AA _o			36		μm
Chip Size				450 x 250		µm x µm
Despensivity	P	λ=1310nm	0.8	0.85		A ()A(
Responsivity	R _λ	λ=1550nm	0.75	0.8		A/W
Capacitance	Cj	V _R =5V		0.16	0.2	pF
Dark Current	I _d	V _R =5V		0.5	2	nA
Breakdown Voltage	V _b	$I_R=1\mu A$	20			v
Bandwidth				9		GHz

(1) Measured with a TIA. Currently FCI-InGaAs-36C is offered in die form only.

FCI-InGaAs-XX-XX-XX

High Speed InGaAs Photodiodes w/Pigtail Packages

The FCI-InGaAs-XX-XX with active area of 75um and 120um are part of OSI Optoelectronics's family of high speed IR sensitive detectors with fiber pigtail package. The single/multi-mode fiber is optically aligned to either the hermetically sealed InGaAs diode in TO-46 lens cap package enhancing the coupling efficiency and stability or directly to the InGaAs diode mounted on a ceramic substrate. High responsivity and low capacitance make these devices ideal for very high-bit rate receivers used in LAN, MAN, WAN and other high speed communication and monitoring/instrumentation systems. Angle polished connectors and custom packages are also available.

For a solution involving FC connector and TO-46 attachment, user(s) may consider either FCI-InGaAs-75-SM-FC or FCI-InGaAs-120-SM-FC in single-mode operation.

Similarily, the multi-mode variant is available in FCI-InGaAs-120-MM-FC using 62.5/125 fiber. The back-reflection of -30dB typical is to be experienced in multi-mode based solution.

APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET/SDH, ATM
- Optical Power Monitoring / Instrumentation

FEATURES

- High Speed
- High Responsivity
- Spectral Range
 900nm to 1700nm
- Low Back Reflection

Absolute Maximum Ratings											
PARAMETERS	SYMBOL	MIN	МАХ	UNITS							
Storage Temperature	T _{stg}	-20	+90	°C							
Operating Temperature	T _{op}	0	+75	°C							

Electro-Optical Characteristic

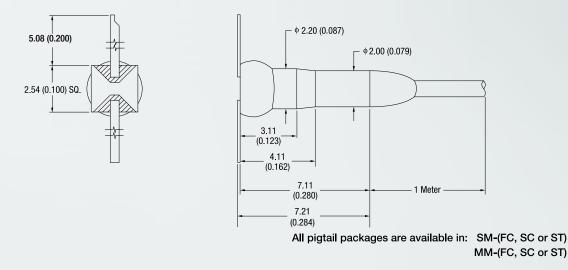
Electro-Opti	Electro-Optical Characteristics										=23°C				
PARAMETERS	SYMBOL	CONDITIONS	FCI-In	GaAs-75-	XX-XX	FCI-In	GaAs-120	-XX-XX	FCI-In	GaAs-75C	-XX-XX	FCI-InG	aAs-1200	C-XX-XX	UNITS
PARAMETERS	STHEOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Active Area Diameter	AA_{ϕ}			75			120			75			120		μm
Deepensivity	D	λ=1310nm	0.75	0.85		0.80	0.90		0.75	0.85		0.80	0.90		A/W
Responsivity	R _λ	λ=1550nm	0.80	0.90		0.85	0.95		0.80	0.90		0.85	0.95		A/ W
Back-Reflection*	RL			-40	-35		-40	-35		-40	-35		-40	-35	dB
Capacitance	Cj	V _R = 5.0V		0.65			1.0			0.65			1.0		pF
Dark Current	I _d	V _R = 5.0V		0.03	2		0.05	2		0.03	2		0.05	2	nA
Rise Time/ Fall Time	t _r /t _f	$V_{R} = 5.0V, R_{L} = 50\Omega$ 10% to 90%			0.2			0.3			0.2			0.3	ns
Max. Reverse Voltage					20			20			20			20	v
Max. Reverse Current					1			2			1			2	mA
Max. Forward Current					5			5			5			5	mA
NEP				3.44E-15			4.50E-15			3.44E-15			4.50E-15		W/√Hz

*Single Mode Fiber (SMF) only



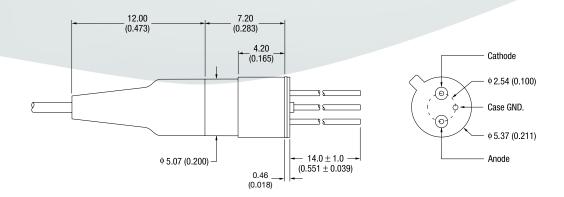






FCI-InGaAs-75C-XX-XX and FCI-InGaAs-120C-XX-XX

FCI-InGaAs-75-XX-XX and FCI-InGaAs-120-XX-XX



All pigtail packages are available in: SM-(FC, SC or ST) MM-(FC, SC or ST)

Notes:

All units in millimeters (inches). All tolerances are 0.125 (0.005)

FCI-InGaAs-XXX-WCER

High Speed InGaAs Photodiodes Mounted on Wraparound Ceramic

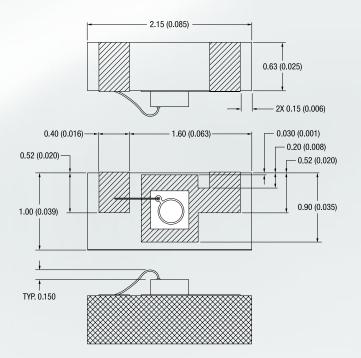
FCI-InGaAs-XXX-WCER with active area sizes of 75µm, 120µm, 300µm, 400µm and 500 $\!\mu m$ are part of a line of monitor photodiodes mounted on metallized ceramic substrates. These compact assemblies are designed for ease of integration. The chips can be epoxy or eutectic mounted onto the ceramic substrate.

APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitor
- Instrumentation

FEATURES

- Low Noise
- High Responsivity



- High Speed
- Spectral Range 900nm to 1700nm



Notes:

• All units in millimeters (inches).

• All devices are eutectic mounted with tolerance of ±50µm.

Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-40	+85	°C						
Operating Temperature	T _{op}	0	+70	°C						
Soldering Temperature	T _{sld}		+260	°C						

Electro-Op	tical Cl	naracteristi	cs														$T_A = 2$	23°C
PARAMETERS	SYMPOL	CONDITIONS	FCI-In	GaAs-7!	5WCER	FCI-In	GaAs-12	OWCER	FCI-In	GaAs-30	OWCER	FCI-In	GaAs-40	OWCER	FCI-In	GaAs-50	OWCER	UNITS
PARAMETERS	STHBUL	CONDITIONS	MIN	TYP	MAX	UNITS												
Active Area Diameter	AA_{ϕ}			75			120			300			400			500		μm
Responsivity	R	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
Responsivity	Γ _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		A, W
Capacitance	Cj	$V_{R} = 5.0V$		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I _d	$V_{R} = 5.0V$		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	V _R = 5.0V, R _L =50Ω 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Reverse Voltage					20			20			15			15			15	v
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

FCI-InGaAs-XXX-ACER

High Speed InGaAs Photodiodes Mounted on Wedge Ceramic Packages

FCI-InGaAs-XXX-ACER with active area sizes of 75µm, 120µm, 300µm, 400µm and 500µm is part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on angled ceramic substrates. The ceramic substrate with an angled surface by 5° greatly reduces the back reflection. The chips can be epoxy/ eutectic mounted onto the angled ceramic substrate.

APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitor
- Instrumentation

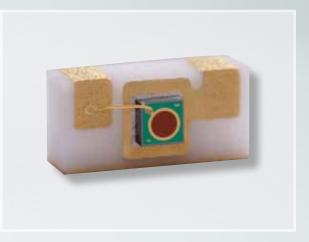
FEATURES

- 5° Angle Ceramic
- Low Noise
- High ResponsivityHigh Speed
- Spectral Range

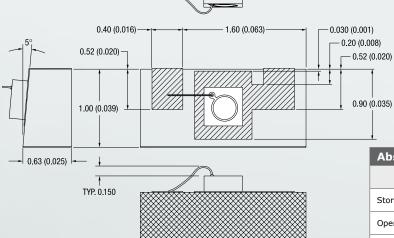
2.15 (0.085)

900nm to 1700nm

0.63 (0.025)



- All units in millimeters (inches).
- All devices are eutectic mounted with tolerance of $\pm 50 \mu m$.



Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-40	+85	°C						
Operating Temperature	T _{op}	0	+70	°C						
Soldering Temperature	T _{sld}		+260	°C						

			_	_	_	_	_	_	_	_		_	_	_	_	_		
Electro-Op	tical Cl	naracteristi																23°C
PARAMETERS	SYMBOL	CONDITIONS	-	nGaAs-7		-	GaAs-12			GaAs-30			GaAs-40			GaAs-50		UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
Active Area Diameter	AA _o			75			120			300			400			500		μm
Responsivity	R	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		μπ
Responsivity	Γλ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		A/W
Capacitance	Cj	$V_{R} = 5.0V$		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	Id	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_{R} = 5.0V,$ $R_{L} = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Reverse Voltage					20			20			15			15			15	v
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

FCI-InGaAs-XXX-LCER

High Speed InGaAs Photodiodes Mounted on Ceramic Packages w/Leads

FCI-InGaAs-XXX-LCER with active area sizes of 75µm, 120µm, 300µm, 400µm and 500µm are part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on gull wing ceramic substrates. The chips can be epoxy/eutectic mounted onto the ceramic substrate.

> - 2.50 SQ. -£

1.25-

- 1.60 ---

APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- Diode Laser Monitoring
- Instrumentation

1.25

Typ 0.150

Т

1.00 ± 0.10

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0.51

FEATURES

- Low Noise
- High Responsivity
- High Speed Spectral Range
 - 900nm to 1700nm

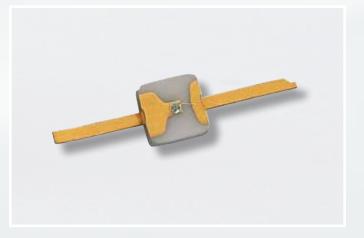
3.81

0.80 Ref.

5.06 2x

Ę

0.10 2x





• All units in millimeters.

• All devices are mounted with low out gassing conductive epoxy with tolerance of ±25µm. Eutectic mounting

is also available upon request.

Absolute Maximum Ratings										
PARAMETERS	SYMBOL	MIN	МАХ	UNITS						
Storage Temperature	T _{stg}	-40	+85	°C						
Operating Temperature	T _{op}	0	+70	°C						
Soldering Temperature	T _{sld}		+260	°C						

Electro-Optical Characteristics T _A =23°C															23°C			
PARAMETERS	SYMBOL	CONDITIONS	FCI-InGaAs-75LCER		FCI-InGaAs-120LCER			FCI-InGaAs-300LCER			FCI-InGaAs-400LCER			FCI-InGaAs-500LCER			UNITS	
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	0.1113
Active Area Diameter	AA_{ϕ}			75			120			300			400			500		μm
Responsivity	_	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
	R _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		
Capacitance	Cj	V _R = 5.0V		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	I _d	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_{R} = 5.0V,$ $R_{L} = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Reverse Voltage					20			20			15			15			15	v
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz

FCI-InGaAs-XXX-CCER

High Speed InGaAs Photodiodes Mounted on Cavity Ceramic Packages

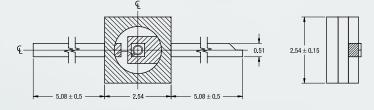
FCI-InGaAs-XXX-CCER with active area sizes of 75µm, 120µm, 300µm, 400µm and 500µm are part of OSI Optoelectronics's high speed IR sensitive photodiodes mounted on gull wing ceramic substrates with glass windows. These devices have a glass window attached to the ceramic where fibers can be directly epoxy mounted onto. The chips can be epoxy or eutectic mounted onto the ceramic substrate. These devices can be provided with custom AR coated windows.

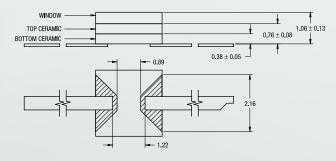
APPLICATIONS

- High Speed Optical Communications
- Gigabit Ethernet/Fibre Channel
- SONET / SDH, ATM
- · Diode Laser Monitoring
- Instrumentation



- Spectral Range
- 900nm to 1700nm





FEATURES

Low Noise High Responsivity

- High Speed



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Notes:

• All units in millimeters. · All devices are mounted with low out gassing

conductive epoxy with tolerance of ±25µm. Eutectic mounting is also available upon request.

Absolute Maximum Ratings											
PARAMETERS	SYMBOL	MIN	МАХ	UNITS							
Storage Temperature	T _{stg}	-40	+85	°C							
Operating Temperature	T _{op}	0	+70	°C							
Soldering Temperature	T _{sld}		+260	°C							

Electro-Optical Characteristics T _A =23°C														23°C				
PARAMETERS	SYMBOL	CONDITIONS	FCI-InGaAs-75CCER			FCI-InGaAs-120CCER			FCI-InGaAs-300CCER			FCI-InGaAs-400CCER			FCI-InGaAs-500CCER			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	01113
Active Area Diameter	AA_{ϕ}			75			120			300			400			500		μm
Responsivity	_	λ=1310nm	0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		0.80	0.90		A/W
	R _λ	λ=1550nm	0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		0.90	0.95		
Capacitance	Cj	$V_R = 5.0V$		0.65			1.0			10.0			14.0			20.0		pF
Dark Current	Id	V _R = 5.0V		0.03	2		0.05	2		0.30	5		0.40	5		0.50	20	nA
Rise Time/ Fall Time	t _r /t _f	$V_R = 5.0V,$ $R_L = 50\Omega$ 10% to 90%			0.20			0.30			1.5			3.0			10.0	ns
Max. Reverse Voltage					20			20			15			15			15	v
Max. Reverse Current					1			2			2			2			2	mA
Max. Forward Current					5			5			8			8			8	mA
NEP				3.44E- 15			4.50E- 15			6.28E- 15			7.69E- 15			8.42E- 15		W/√Hz